

**Search Notes**

Application/Control No.

10/766,487

Examiner

David Buttner

Applicant(s)/Patent under  
Reexamination

KOBAYASHI ET AL.

Art Unit

1712

**SEARCHED**

| Class | Subclass | Date | Examiner |
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**INTERFERENCE SEARCHED**

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| 525   | all      | 1/24/2007 | DB       |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|                 | DATE      | EXMR |
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| chem ab         | 1/23/2007 | DB   |
| west            | 1/23/2007 | DB   |
| west            | 1/23/2007 | DB   |
| east            | 1/24/2007 | DB   |
| east            | 1/24/2007 | DB   |
| inventor search | 1/24/2007 | DB   |
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